Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/576,784	VAN DER SCHAAF ET AL.	
Examiner	Art Unit	
Karen Cheng	1626	

SEARCHED				
Class	Subclass	Date	Examiner	
	_			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
STN Structure Search (see attached)	3/9/2007	кс
EAST Search (see attached)	3/9/2007	кс
Inventor Name Search (PALM)	3/12/2007	Ke